

## P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ $I_{D}(A)$		Q <sub>g</sub> (Typ.)		
- 30	0.032 at V <sub>GS</sub> = - 10 V	-2.4	5.1 nC		
	0.042 at V <sub>GS</sub> = - 4.5 V	- 2.0	5.1110		

#### **FEATURES**

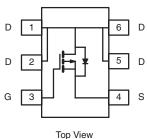
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET

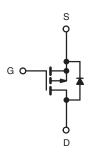
# COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

· Load Switch







P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	- 30	V	
Gate-Source Voltage		$V_{GS}$	± 20	V	
	T <sub>C</sub> = 25 °C		- 2.4		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 2.1		
Continuous Brain Current (1) = 130 C)	T <sub>A</sub> = 25 °C		- 2.1 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	]	- 1.8 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	- 20		
	T <sub>C</sub> = 25 °C		- 2.5		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 1.67 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		2.0		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.0	W	
	T <sub>A</sub> = 25 °C		1.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	]	0.8 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	$R_{thJA}$	55	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	34	41	] 0,77	

- a. Based on T<sub>C</sub> = 25 °C.
  b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 110 °C/W.

服务热线:400-655-8788



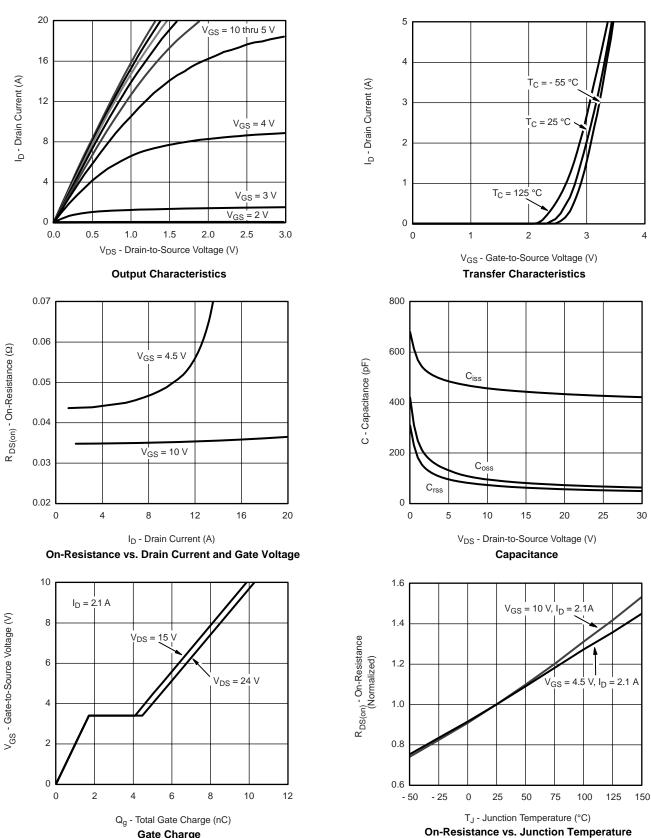
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					L		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250 A		- 31		1406	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		4.5		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μА	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α	
		$V_{GS} = -10 \text{ V}, I_D = -2.1 \text{ A}$		0.032		<del> </del>	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -1.0 \text{ A}$		0.042		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 2.1 A		8		S	
Dynamic <sup>b</sup>				<u> </u>			
Input Capacitance	C <sub>iss</sub>			450		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		80			
Reverse Transfer Capacitance	C <sub>rss</sub>			63			
Total Gate Charge		V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 2.1 A		10	15	nC	
	$Q_g$			5.1	8		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -2.1 \text{ A}$		1.8			
Gate-Drain Charge	$Q_{gd}$			2.5			
Gate Resistance	$R_{g}$	f = 1 MHz		7		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			40	60	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 4.6 $\Omega$		80	120		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 3.3 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		20	30		
Fall Time	t <sub>f</sub>			12	20		
Turn-On Delay Time	t <sub>d(on)</sub>			5	10		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 4.6 $\Omega$		13	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 3.3 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		20	30		
Fall Time	t <sub>f</sub>			10	15		
<b>Drain-Source Body Diode Characteristi</b>	cs						
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			- 2.5	Λ	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 20	1 A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 3.3 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			20	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 22 A di/dt 100 A/vo T 25 °C		20	30	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -3.3 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		14			
Reverse Recovery Rise Time t <sub>b</sub>			6		ns		

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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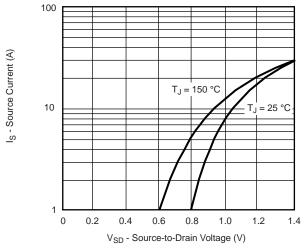


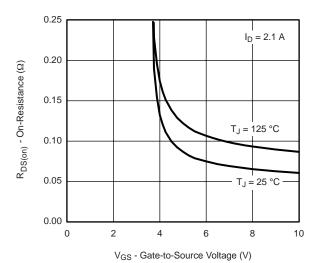


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**Gate Charge** 

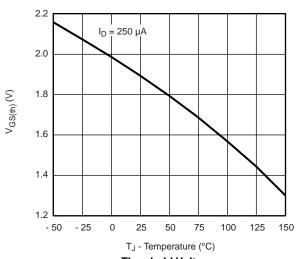






#### Source-Drain Diode Forward Voltage







**Threshold Voltage** 

100

Limited by R<sub>DS(on)</sub>\* 10 I<sub>D</sub> - Drain Current (A) 0.1 T<sub>A</sub> = 25 °C Single Pulse BVDSS Limited 0.01 0.1

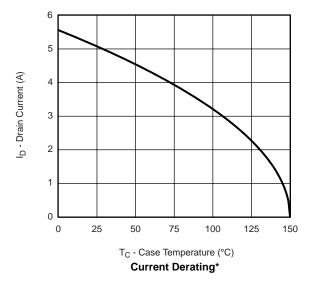
V<sub>DS</sub> - Drain-to-Source Voltage (V)

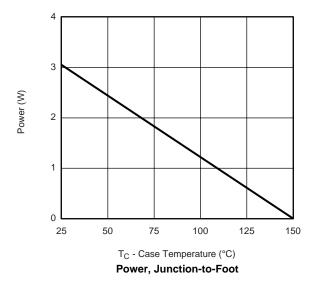
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

100

Safe Operating Area



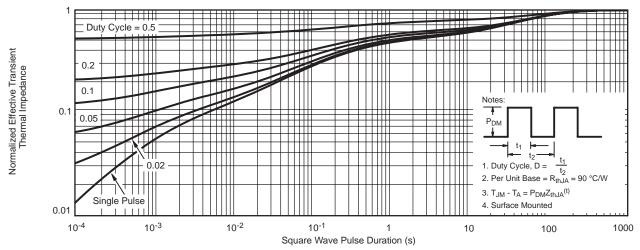




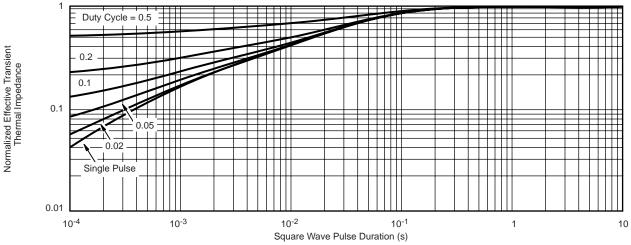
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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